UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/591,945	09/08/2006	Hiroshi Fujisawa	1752-0187PUS1	8000
	7590 12/03/200 ART KOLASCH & BI	EXAMINER		
PO BOX 747	CH 3/4 22040 0747	IEVA, NICHOLAS		
FALLS CHURCH, VA 22040-0747			ART UNIT	PAPER NUMBER
		2836		
			NOTIFICATION DATE	DELIVERY MODE
			12/03/2008	ELECTRONIC

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

mailroom@bskb.com

Advisory Action Before the Filing of an Appeal Brief

Application No.	Applicant(s)	
10/591,945	FUJISAWA ET AL.	
Examiner	Art Unit	

	NICHOLAS IEVA	2836	
The MAILING DATE of this communication appe	ears on the cover sheet with the c	correspondence add	ress
THE REPLY FILED <u>07 November 2008</u> FAILS TO PLACE THIS	S APPLICATION IN CONDITION F	OR ALLOWANCE.	
1. The reply was filed after a final rejection, but prior to or on application, applicant must timely file one of the following application in condition for allowance; (2) a Notice of Application (RCE) in compliance with 37 Comperiods:	the same day as filing a Notice of a replies: (1) an amendment, affidavi eal (with appeal fee) in compliance	Appeal. To avoid abar t, or other evidence, w with 37 CFR 41.31; or	hich places the (3) a Request
a) The period for reply expires <u>3</u> months from the mailing date	of the final rejection.		
b) The period for reply expires on: (1) the mailing date of this A no event, however, will the statutory period for reply expire I Examiner Note: If box 1 is checked, check either box (a) or MONTHS OF THE FINAL REJECTION. See MPEP 706.07(ater than SIX MONTHS from the mailing (b). ONLY CHECK BOX (b) WHEN THE	g date of the final rejection	n.
Extensions of time may be obtained under 37 CFR 1.136(a). The date have been filed is the date for purposes of determining the period of exunder 37 CFR 1.17(a) is calculated from: (1) the expiration date of the set forth in (b) above, if checked. Any reply received by the Office later may reduce any earned patent term adjustment. See 37 CFR 1.704(b) NOTICE OF APPEAL	on which the petition under 37 CFR 1.1 tension and the corresponding amount of the chartened statutory period for reply origing than three months after the mailing dat	of the fee. The appropria nally set in the final Offic	te extension fee e action; or (2) as
2. The Notice of Appeal was filed on A brief in comp filing the Notice of Appeal (37 CFR 41.37(a)), or any exte Notice of Appeal has been filed, any reply must be filed w AMENDMENTS	nsion thereof (37 CFR 41.37(e)), to	avoid dismissal of the	
3. The proposed amendment(s) filed after a final rejection,	out prior to the date of filing a brief	will not be entered be	cause
(a) ☐ They raise new issues that would require further co			oauoo
(b) They raise the issue of new matter (see NOTE belo		,	
(c) They are not deemed to place the application in bet	ter form for appeal by materially red	ducing or simplifying th	ne issues for
appeal; and/or (d) ☐ They present additional claims without canceling a ∈	corresponding number of finally reig	otod claims	
NOTE: <u>See Continuation Sheet</u> . (See 37 CFR 1.1		ected claims.	
4. The amendments are not in compliance with 37 CFR 1.1		mnliant Amendment (I	PTOL-324)
5. Applicant's reply has overcome the following rejection(s)		impliant / imenament (i	102 02-7.
6. Newly proposed or amended claim(s) would be al		timely filed amendmer	t canceling the
non-allowable claim(s).	Mill not be entered on b) Mil	lbe entered and an ev	unlamation of
7. For purposes of appeal, the proposed amendment(s): a) how the new or amended claims would be rejected is provide the status of the claim(s) is (or will be) as follows:		r be entered and an ex	kpianation of
Claim(s) allowed:			
Claim(s) objected to: Claim(s) rejected:			
Claim(s) rejected: Claim(s) withdrawn from consideration:			
AFFIDAVIT OR OTHER EVIDENCE			
 The affidavit or other evidence filed after a final action, but because applicant failed to provide a showing of good and was not earlier presented. See 37 CFR 1.116(e). 			
 The affidavit or other evidence filed after the date of filing entered because the affidavit or other evidence failed to of showing a good and sufficient reasons why it is necessary 	vercome <u>all</u> rejections under appea	al and/or appellant fails	to provide a
10.		•	
11. The request for reconsideration has been considered bu See Continuation Sheet.	t does NOT place the application in	condition for allowand	ce because:
12. ☑ Note the attached Information <i>Disclosure Statement</i> (s). 13. ☐ Other:	(PTO/SB/08) Paper No(s). <u>09/10/20</u>	008	
	/Stephen W Jackson/ Primary Examiner, Art U	nit 2836	

Continuation of 3. NOTE: The newly added claims 26 and 28 comprises a limitation that raises new issues. The limitation "the first electrode and second electrode and being applied voltages that are different in polarity or one electrode being grounded while the other one is set to a positive electrode or a negative electrode" of claim 26 would require further consideration and/or search. The limitation "wherein said bipolar electrostatic chuck is capable of attractring an insulating substrate" of claim 28 would require further consideration and/or search. Futhermore, claim 27 raises new issues because if claim 1 should be found allowable, claim 27 would be objected to under 37 CFR 1.75 as being a substantial duplicate thereof (when two claims in an application are duplicates or else are so close in content that they both cover the same thing, despite a slight difference in wording, it is proper after allowing one claim to object to the other as being a substantial duplicate of the allowed claim. See MPEP § 706.03(k).).

Continuation of 11. does NOT place the application in condition for allowance because: The newly added claims 26, 27 and 28 raise new issues, which would require further consideration and/or search. Futhermore, the Examiner respectfully disagrees with the Applicant that the combination of Shamoulilian and Benjamin does not teach a bipolar electrostatic chuck which has a first electrode and a second electrode in an interior of an insulating material, generates at least an attracting performance by a gradient force, and attracts a sample by allowing a surface of the insulating material to function as a sample attracting plane, characterized in that: the insulating material is formed by laminating an upper insulating layer, the first electrode, an interelectrode insulating layer, the second electrode, and a lower insulating layer in the order of distance from the sample attracting plane in a depth direction of the insulating material; and when the sample attracting plane is viewed in a depth direction, the second electrode has an area that is not overlapped with the first electrode, a plurality of first electrodes and a plurality of second electrodes being alternately arranged in a direction in which the area that is not overlapped is crossed a plurality of times.

Shamouilian et al. discloses a bipolar electrostatic chuck which has a first electrode 24 and a second electrode 22 in an interior of an insulating material 26, said first electrode connected to a first voltage source 48 and said second electrode connected to a second voltage source 46 generates at least an attracting performance by a gradient force, and is capable of attracting a sample by allowing a surface of the insulating material to function as a sample attracting plane, characterized in that: the insulating material 26 comprises an upper insulating layer 26c, the first electrode 24, an inter-electrode insulating layer 26b, the second electrode 22, and a lower insulating layer 26a which are by laminated in the order of distance from the sample attracting plane; and when the insulating material is viewed from a side cross-sectional view, the first electrode has a plurality of gaps, and the second electrode has a plurality of areas that are not overlapped with the first electrode (Shamouilian; figures 1 and 2b; column 2, line 54 - column 3, line 47; column 4, lines 34-62; column 3, line 56 - column 5, lines 60-67).

Benjamin et al. teaches a first electrode 44 and a second electrode 42, said first electrode and said second electrode are applied voltages that are different from each other (bipolar implementation), generates at least an attracting performance by a gradient force, and is capable of attracting a sample by allowing a surface of the insulating material to function as a sample attracting plane, characterized in that: the insulating material 36 comprises an upper insulating layer 40, the first electrode 44, an inter-electrode insulating layer (the insulating layer between said first and second electrode), and the second electrode 42, which are laminated in the order of distance from the sample attracting plane.

Furthermore, the bipolar arrangement of Shamoulian's first or second electrode would generate at least an attracting performance by a gradient force, and would attract a sample by allowing a surface of the insulating material to function as a sample attracting plane, and the the bipolar arrangement of Benjamin's first and second electrodes would also generate at least an an attracting performance by a gradient force and would attract a sample by allowing a surface of the insulating material to function as a sample attracting plane. The Applicant admits on page 14 of his arguments filed on 07 March 2008 that a bipolar arrangement of the electrodes would produce a gradient force. The strength of the gradient force is not claimed, what matters is that the combination of Shamoulilian and Benjamin does indeed met the claimed limitations. The strength of the gradient force will be controlled my a number for factors which include the voltage applied to the first and second electrodes, the distance between the first and second electrodes, the size and sample of the electrodes, and the position/placement of the first and second electrodes.